

# **FCC TEST REPORT**

Test report
On Behalf of
ShangXing Technology(ShenZhen) Co.,Ltd.
For

3 in1 Magnetic Phone Stand Wireless Charger

Model No.: X23, X23S, X23 Pro, X23 Plus, X32, X32 Pro, X32 Plus,
S310, S313, S313 Pro, S313 Plus, S111

FCC ID: 2APDM-X23

Prepared For: ShangXing Technology(ShenZhen) Co.,Ltd.

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Date of Test: Oct. 20, 2022 ~ Oct. 27, 2022

Date of Report: Oct. 27, 2022

Report Number: HK2210204635-2E



Note:

1. For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.

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HUAK		HUAKIL	Chani	nel List	HUA	Kin	HUAK
Channel	Frequency (KHz)	Channel	Frequency (MHz)	Channel	Frequency (MHz)	Channel	Frequency (MHz)
01	125	MAKTE		TING	WAKTE		TING
MAKTES	(0)	2	MAKTE		(a)	S 42	JAKTES
			(D)				
		STING	670		TESTING	J.J. (1 × 1 × 1 × 1 × 1 × 1 × 1 × 1 × 1 × 1	

The EUT antenna is Coil Antenna. No antenna other than that furnished by the responsible party shall be used with the device.

#### 2. SUMMARY OF TEST RESULTS

2.1. Test procedures according to the technical standards:
FCC KDB680106 D01 RF Exposure Wireless Charging Apps v03r01

	- 1/ 37	-4117	- (/)	-4114
		FCC CFR 47		
Standard Section		Test Item	Judgment	Remark
FCC CFR 47 part1,	Electric Fig	eld Strength (E) (V/m)	PASS	MAK TESTING
1.1310 KDB680106 - D01v03r01 (3)(3)	Magnetic F	ield Strength (H) (A/m)	PASS	LAY TESTINE

#### 2.2. Measurement Uncertainty

The reported uncertainty of measurement  $\mathbf{y} \pm \mathbf{U}$ , where expended uncertainty  $\mathbf{U}$  is based on a standard uncertainty multiplied by a coverage factor of  $\mathbf{k=2}$ , providing a level of confidence of approximately  $\mathbf{95}$  %.

No.		Item wat to	Uncertainty
	1	All emissions, radiated(<30M)(9KHz-30MHz)	±3.90dB
STING	2	Temperature	±0.5°C
	3 HUAN	Humidity	±2%

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## 2.3. Test Instruments

_	- CCC/		430		-500	
	Description	Brand	Model No.	Frequency Range	Calibrated Date	Calibrated Until
JP	Exposure Level Tester	narda	ELT-400	N-0231	Feb. 18, 2022	Feb. 17, 2023
65	Magnetic field probe 100cm <sup>2</sup>	narda	ELT probe 100cm2	M0675	Feb. 18, 2022	Feb. 17, 2023

NOTE: 1. The calibration interval of the above test instruments is 12 months.

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### 3. MAXIMUM PERMISSIBLE EXPOSURE

### Limit of Maximum Permissible Exposure

	Limits for Occ	cupational / Controlle	ed Exposure	
Frequency Range (MHz)	Electric Field Strength (E) (V/m)	Magnetic Field Strength (H) (A/m)	Power Density (S) (mW/ cm²)	Averaging Time    E  <sup>2</sup> , H  <sup>2</sup> or S (minutes)
0.3-3.0	614	1.63	(100)*	6
3.0-30	1842 / f	4.89 / f	(900 / f)*	6
30-300	61.4	0.163	1.0	6
300-1500	- JUAK TESTI		F/300	6
1500-100,000	110 D	TESTING ON TESTING	5	STING 6 NYTESTING
	Limits for General	Population / Uncon	trolled Exposure	
Frequency Range (MHz)	Electric Field Strength (E) (V/m)	Magnetic Field Strength (H) (A/m)	Power Density (S) (mW/ cm²)	Averaging Time  E 2, H 2 or S (minutes)
0.3-1.34	614	1.63	(100)*	30
1.34-30	824/f	2.19/f	(180 / f)*	30
30-300	27.5	0.073	0.2	30
300-1500		O HUA	F/1500	30
1500-100,000	NK TESTING		OK TET THE	30

Note 1: f = frequency in MHz; \*Plane-wave equivalent power density.

Note 2: For the applicable limit, see FCC 1.1310, 680106 D01 RF Exposure Wireless Charging Apps v03r01.

Note 3: Emissions between 100 kHz to 300 kHz should be assessed versus the limits at 300 kHz in Table 1 of Section 1.1310: 614 V/m and 1.63A/m. A KDB inquiry is required to determine the applicable exposure limits below 100 kHz.

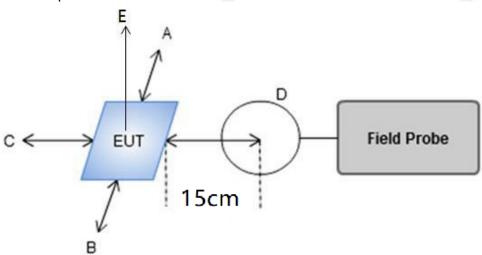


### 4. TEST PROCEDURE

a. For devices designed for typical desktop applications, such a wireless charging pads, RF exposure evaluation should be conducted assuming a user separation distance of (H-field & E- field strengths for all sides is 15cm, H-field strengths of top side is 20cm).

E and H field strength measurements or numerical modeling may be used to demonstrate compliance. Measurements should be made from all sides and the top of the primary/client pair, with the 15 cm measured from the center of the probe(s) to the edge of the device.

#### 4.1 Test Setup



4.2 Result Of Maximum Permissible Exposure

All test modes are tested, and the report shows only the worst mode: ANT1+ANT2+ANT3

For Full load mode:

H-Field Strength at 15 cm (E top side: 20cm) from the edges surrounding the EUT (A/m)

Field strength	Test Position A	Test Position B	Test Position C	Test Position D	Test Position E	Limits (A/m)
<sup>©</sup> uT	0.471	0.358	0.618	0.527	0.579	STING /
A/m	0.377	0.286	0.494	0.422	0.463	1.63

Note.

Calculation: A/m=uT/1.25

For Half Load mode:

H-Field Strength at 15 cm (E top side: 20cm) from the edges surrounding the EUT (A/m)

Field strength	Test Position A	Test Position B	Test Position C	Test Position D	Test Position E	Limits (A/m)
<sup>©</sup> uT	0.438	0.357	0.708	0.359	0.440	NG /
A/m	0.350	0.286	0.566	0.287	0.352	1.63

Note.

Calculation: A/m=uT/1.25

For No load mode:

H-Field Strength at 15 cm (E top side: 20cm) from the edges surrounding the EUT (A/m)

Field strength	Test Position	Test Position B	Test Position	Test Position	Test Position	Limits (A/m)
uT	0.548	0.414	0.392	0.451	0.617	/
A/m	0.438	0.331	0.314	0.361	0.494	1.63

Note.

Calculation: A/m=uT/1.25





Remark: According KDB 680106 D01 RF Exposure Wireless Charging App v03r01, section 5, b). The aggregate H-field strengths at 15 cm surrounding the device and 20 cm above the top surface from all simultaneous transmitting coils are demonstrated to be less than 50% of the MPE limit. The E- field evaluation conducted assuming a user separation distance of 15 cm according to the KDB 680106 D01 RF Exposure Wireless Charging App v03r01 section 3, c).

Result: The device comply with the RF exposure requirement according to 680106 D01 v03r01, section 5, b):

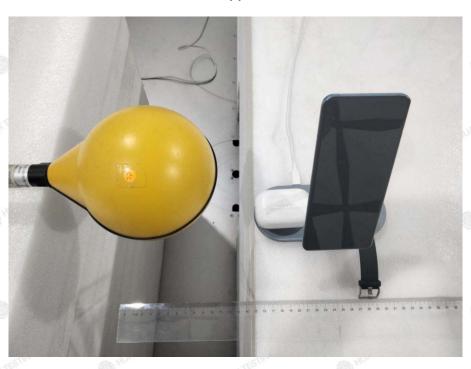
- (1) Power transfer frequency is less than 1 MHz.
- -The device operate in the frequency range for 111.5KHz~205KHz
  - (2) Output power from each primary coil is less than or equal to 15 watts.
    - The maximum output power of ANT1 is 15W
    - The maximum output power of ANT2 is 10W
    - The maximum output power of ANT3 is 5W
  - (3) The system may consist of more than one source primary coils, charging one or more clients. If more than one primary coil is present, the coil pairs can be powered on at the same time
- The transfer system including a charging system with three primary coils, the coil pairs can be powered on at the same time.
  - (4) Client device is placed directly in contact with the transmitter
- The EUT is placed directly in contact with the transmitter
  - (5) Mobile exposure conditions only (portable exposure conditions are not covered by this exclusion).
- Yes, mobile device only.
- (6) The aggregate H-field strengths anywhere at or beyond 15 cm surrounding the device, and 20 cm away from the surface from all coils that by design can simultaneously transmit, and while those coils are simultaneously energized, are demonstrated to be less than 50% of the applicable MPE limit.
  - The EUT meet the conditions.



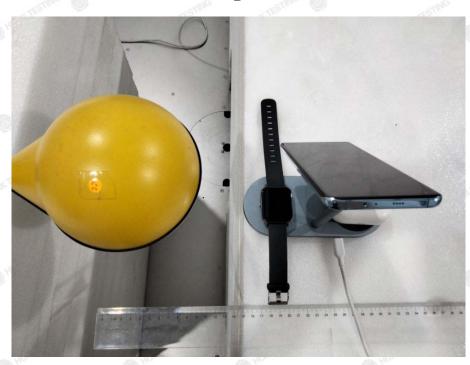


# PHOTOGRAPH OF TEST

Α



В



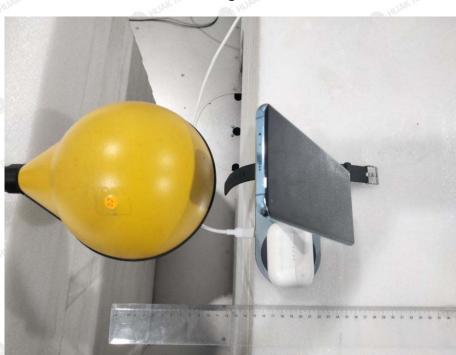
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C



D



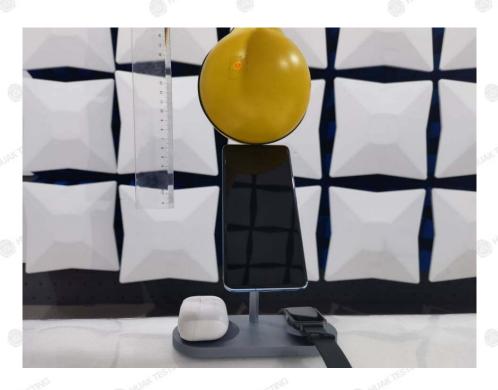


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